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Določevanje posameznih snovi v elektrotehničnih izdelkih - 2. del: Razstavljanje, odklop in mehanska priprava vzorca

Determination of certain substances in electrotechnical products - Part 2: Disassembly, disjunction and mechanical sample preparation

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Détermination de certaines substances dans les produits électrotechniques - Partie 2: Démontage, désassemblage et préparation mécanique de l'échantillon

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EUROPEAN STANDARD

EN IEC 62321-2

NORME EUROPÉENNE

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October 2021

ICS 13.020.01; 43.040.10

Supersedes EN 62321-2:2014 and all of its amendments
and corrigenda (if any)

English Version

**Determination of certain substances in electrotechnical products
- Part 2: Disassembly, disjointment and mechanical sample
preparation
(IEC 62321-2:2021)**

Détermination de certaines substances dans les produits
électrotechniques - Partie 2: Démontage, défabrication et
préparation mécanique de l'échantillon
(IEC 62321-2:2021)

Verfahren zur Bestimmung von bestimmten Substanzen in
Produkten der Elektrotechnik - Teil 2: Demontage,
Zerlegung und mechanische Probenvorbereitung
(IEC 62321-2:2021)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN IEC 62321-2:2021 (E)**European foreword**

The text of document 111/619/FDIS, future edition 2 of IEC 62321-2, prepared by IEC/TC 111 “Environmental standardization for electrical and electronic products and systems” was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62321-2:2021.

The following dates are fixed:

- latest date by which the document has to be implemented at national (dop) 2022-07-04 level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with the (dow) 2024-10-04 document have to be withdrawn

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Endorsement notice

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

- IEC 62554:2011 NOTE Harmonized as EN 62554:2011 (not modified)
- IEC 63000:2016 NOTE Harmonized as EN IEC 63000:2018 (not modified)
- IEC 62137-1-2:2007 NOTE Harmonized as EN 62137-1-2:2007 (not modified)
- IEC 62239-1:2018 NOTE Harmonized as EN IEC 62239-1:2018 (not modified)

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
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**Determination of certain substances in electrotechnical products –
Part 2: Disassembly, disjointment and mechanical sample preparation**

**Détermination de certaines substances dans les produits électrotechniques –
Partie 2: Démontage, défabrication et préparation mécanique de l'échantillon**

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CONTENTS

FOREWORD.....	5
INTRODUCTION.....	7
1 Scope.....	8
2 Normative references	8
3 Terms, definitions and abbreviated terms	9
3.1 Terms and definitions.....	9
3.2 Abbreviated terms.....	9
4 Introduction to sampling	10
4.1 Introductory remarks.....	10
4.2 Requirements for certain substances	10
4.3 Complexity of electrotechnical products and related challenges	11
4.4 Sampling procedure	12
4.5 Scope of the analysis.....	13
4.6 Purpose of the analysis.....	14
4.7 Testing strategy	14
5 Sampling plan.....	15
5.1 Introductory remarks.....	15
5.2 Sampling of a complete product.....	15
5.3 Partial disassembly.....	16
5.4 Complete disassembly.....	16
5.5 Partial disjointment	16
5.6 Complete disjointment	16
5.7 Test sample considerations.....	17
5.7.1 Introductory remarks.....	17
5.7.2 Required sample size	17
5.7.3 Sample size versus detection limit	18
5.7.4 Composite sample considerations.....	19
5.7.5 Non-uniform "homogeneous materials"	19
5.7.6 Determination of sampling of homogeneous materials from different positions.....	21
6 Conclusions and recommendations for sampling	21
7 Mechanical sample preparation	21
7.1 Overview.....	21
7.1.1 Field of application	21
7.1.2 Quality assurance.....	22
7.2 Apparatus, equipment and materials	22
7.3 Procedure.....	23
7.3.1 General	23
7.3.2 Manual cutting	23
7.3.3 Coarse grinding or milling.....	23
7.3.4 Homogenizing.....	23
7.3.5 Fine grinding or milling	23
7.3.6 Very fine grinding of polymers and organic materials	24
Annex A (informative) Examples of procedures for sampling and disjointment	25
Annex B (informative) Probability of the presence of certain substances.....	33
Annex C (informative) Composite testing and sampling.....	37

C.1	Introductory remarks	37
C.2	Calculated maximum concentration for a composite sample based on detection limit	37
C.3	Required detection limit for a composite sample based on the maximum allowable concentration	38
Annex D (informative)	Tools used in sampling.....	40
Annex E (informative)	Examples of mobile phone disassembly and disjointment	41
E.1	General.....	41
E.2	Partial disassembly without tools – Mobile phone type A.....	41
E.3	Partial disassembly with simple tools – Mobile phone type B.....	43
E.4	Complete disassembly – Mobile phone type B	44
E.5	Partial disjointment – Mobile phone type B.....	45
E.6	Complete disjointment – Examples of disjointment of small electronic parts	46
E.7	Complete disjointment of integrated circuit lead frame package	48
E.8	Complete disjointment of ball grid array (BGA) package.....	48
E.8.1	General	48
E.8.2	Solder ball removal from BGA package – Hand removal procedure.....	49
E.8.3	Solder ball removal from BGA package – Solder ball shear procedure.....	50
Bibliography	51
Figure 1	– Generic iterative procedure for sampling.....	12
Figure 2	– Cross-section of a 900 µm wide lead oxide-based resistor (SMD)	20
Figure A.1	– Methodology for sampling and disjointment.....	26
Figure A.2	– Sampling of DVD player.....	27
Figure A.3	– Sampling of LCD TV.....	28
Figure A.4	– Sampling of PDA	29
Figure A.5	– Sampling of desk fan	30
Figure A.6	– Sampling of parts – Thick film resistor	31
Figure A.7	– Sampling of parts – SMD potentiometer	32
Figure D.1	– Hot gas gun for removing electronic parts.....	40
Figure D.2	– Vacuum pin to remove target electronic devices	40
Figure E.1	– Mobile phone type A with battery charger and camera lens cap	41
Figure E.2	– Mobile phone type A with battery and back cover removed	42
Figure E.3	– Partial disassembly of a mobile phone (type B) into its major parts	43
Figure E.4	– Complete disassembly of key pad.....	44
Figure E.5	– Complete disassembly of bottom housing	44
Figure E.6	– Complete disassembly of other housing or frame	45
Figure E.7	– Parts of the TFT display of the mobile phone (type B) after partial disjointment	45
Figure E.8	– Parts of the main PCB of the mobile phone (type B) after partial disjointment	46
Figure E.9	– Disjointment of lead frame	48
Figure E.10	– BGA package prior to disjointment	49
Figure E.11	– BGA package disjointed by hand removal procedure.....	49
Figure E.12	– Solder ball material collected from BGA using hand removal procedure	50
Figure E.13	– BGA solder ball removal using ball shear procedure	50

Table 1 – Minimum number of lead frame samples required for analytical testing	17
Table 2 – Levels of a certain substance (e.g. Pb) in a composite sample	19
Table B.1 – Probability of the presence of certain substances in materials and parts used in electrotechnical products	33
Table B.2 – Probability of the presence of additional certain substances in polymeric materials.....	36
Table C.1 – Calculated maximum concentration for a composite sample based on detection limit	38
Table C.2 – Required detection limit for a composite sample based on the maximum allowable concentration	39
Table E.1 – Possible certain substances or screening substances from a mobile phone (type A).....	42
Table E.2 – Possible certain substances in major parts of the mobile phone (type B).....	43
Table E.3 – Examples of disjointment for typical small electronic parts	47

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**DETERMINATION OF CERTAIN SUBSTANCES
IN ELECTROTECHNICAL PRODUCTS –****Part 2: Disassembly, disjointment and mechanical sample preparation**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

IEC 62321-2 has been prepared by IEC technical committee 111: Environmental standardization for electrical and electronic products and systems. It is an International Standard.

This second edition cancels and replaces the first edition published in 2013. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) Reference to the IEC 62321 series instead of to a list of individual parts of the IEC 62321 series.
- b) Update of the flow chart in Figure 1. Restructure of Clause 4 and update of examples in Annex A.

- c) Adjustment of the risk levels of certain parts and materials to reflect the recent technology development and material change. Update of Table B.1 to include the risk levels of phthalates. Creation of Table B.2 for other substances (e.g. HBCDD, PAH) in polymeric materials.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
111/619/FDIS	111/628/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

A list of all parts in the IEC 62321 series, published under the general title *Determination of certain substances in electrotechnical products*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed, [SIST EN IEC 62321-2:2022](https://standards.iteh.ai/catalog/standards/sist/f6aaa2ce-ce05-4db9-b664-1dd97e6cacff/sist-en-iec-62321-2-2022)
- withdrawn, <https://standards.iteh.ai/catalog/standards/sist/f6aaa2ce-ce05-4db9-b664-1dd97e6cacff/sist-en-iec-62321-2-2022>
- replaced by a revised edition, or
- amended.

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INTRODUCTION

The widespread use of electrotechnical products has drawn increased attention to their impact on the environment. In many countries this has resulted in the adaptation of regulations affecting wastes, substances and energy use of electrotechnical products.

The use of certain substances in electrotechnical products is a source of either concern or importance in current and proposed regional legislations.

The purpose of the IEC 62321 series is therefore to provide test methods that will allow the electrotechnical industry to determine the levels of certain substances in electrotechnical products on a consistent global basis. This document, as an important part of the IEC 62321 series, covers strategies of sampling along with the mechanical preparation.

WARNING – Persons using this document should be familiar with normal laboratory practice. This document does not purport to address all of the safety problems, if any, associated with its use. It is the responsibility of the user to establish appropriate safety and health practices and to ensure compliance with any national regulatory conditions.

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DETERMINATION OF CERTAIN SUBSTANCES IN ELECTROTECHNICAL PRODUCTS –

Part 2: Disassembly, disjointment and mechanical sample preparation

1 Scope

This part of IEC 62321 provides strategies of sampling along with the mechanical preparation of samples from electrotechnical products. These samples can be used for analytical testing to determine the levels of certain substances as described in the test methods in other parts of the IEC 62321 series. Restrictions for substances will vary between geographic regions and can be updated on a regular basis. This document describes a generic process for obtaining and preparing samples prior to the determination of any substance of concern.

This document does not provide:

- full guidance on each and every product that could be classified as electrotechnical product. Since there is a huge variety of electrotechnical parts, with various structures and compositions, along with the continuous innovations in the industry, it is unrealistic to attempt to provide procedures for the disjointment of every type of part;
- guidance regarding other routes to gather additional information on certain substances in a product, although the information collected has relevance to the sampling strategies in this document;
- safe disassembly and mechanical disjointment instructions related to electrotechnical products (e.g. mercury-containing switches) and the recycling industry (e.g. how to handle CRTs or the safe removal of batteries). See IEC 62554 [1] for the disjointment and mechanical sample preparation of mercury-containing fluorescent lamps;
- sampling procedures for packaging and packaging materials;
- analytical procedures to measure the levels of certain substances. This is covered by other standards (e.g. other parts of the IEC 62321 series), which are referred to as "test standards" in this document;
- guidelines for assessment of compliance.

This document has the status of a horizontal standard in accordance with IEC Guide 108 [2].

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62321 (all parts), *Determination of certain substances in electrotechnical products*

¹ Numbers in square brackets refer to the bibliography.

3 Terms, definitions and abbreviated terms

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 62321-1 and the following apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

3.1.1

composite testing

testing of two or more materials as a single sample that could be mechanically disjointed if necessary

3.1.2

certain substance

substance subject to test methods developed or under development in IEC 62321 (all parts), such as cadmium, lead, mercury, hexavalent chromium, polybrominated biphenyl, polybrominated diphenyl ether, phthalates

Note 1 to entry: IEC 62321-1 includes test methods for the evaluation of each of the substances identified in the definition above.

3.1.3

disassembly

process whereby an item is taken apart in such a way that it could subsequently be reassembled and made operational

3.1.4

disjointment

process whereby materials are separated by mechanical means such that the item cannot subsequently be reassembled to make it operational

3.1.5

homogeneous material

one material of uniform composition throughout or a material, consisting of a combination of materials, that cannot be disjointed or separated into different materials by mechanical actions such as unscrewing, cutting, crushing, grinding and abrasive processes

[SOURCE: EU RoHS DIRECTIVE 2011/65/EU [3]]

3.1.6

sampling

process of obtaining a sample of an electrotechnical product intended for the analysis for the presence of certain substance(s)

3.2 Abbreviated terms

AC	alternating current
BGA	ball grid array
CRT	cathode ray tube (television)
DVD	digital versatile disc
IC	integrated circuit
ICP-MS	inductively coupled plasma mass spectrometry